

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S73	1	"20060156111".did.	US-PGPUB; USPAT	OR	ON	2006/11/01 14:49
S1	2370	(345/204).CCLS.	US-PGPUB; USPAT	OR	OFF	2006/11/01 14:49
S75	14753	((327/291) or (348/180) or (345/94,92,104,100,98,87,76,204,208) or (315/169.1-169.4) or (326/9,11-14,52,54)).CCLS.	US-PGPUB; USPAT	OR	OFF	2006/11/01 14:57
S74	1	"05256914".did.	JPO	OR	ON	2006/11/01 14:57
S79	66	S77 and S78	US-PGPUB; USPAT	OR	ON	2006/11/01 14:58
S78	22566	(inspect\$4 checking test\$3) adj circuit	US-PGPUB; USPAT	OR	ON	2006/11/01 14:58
S77	1129	S75 and S76	US-PGPUB; USPAT	OR	ON	2006/11/01 14:58
S76	63260	NAND	US-PGPUB; USPAT	OR	ON	2006/11/01 14:58
S84	87519	NAND	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/01 15:22
S83	4597981	circuit	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/01 15:22
S82	2219882	display	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/01 15:22
S81	361291	pixel	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/01 15:22

## EAST Search History

S85	7528522	inspect\$6 compar\$5 determin\$6 test\$3 check\$6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/01 15:23
S80	2142778	defect\$5 damag\$6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/01 15:24
S92	723	S86 and S87 and S88 and S89 and S90 and S91	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/02 08:23
S91	7533304	inspect\$6 compar\$5 determin\$6 test\$3 check\$6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/02 08:23
S90	87594	NAND	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/02 08:23
S89	4600172	circuit	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/02 08:23
S88	2221758	display	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/02 08:23
S87	361752	pixel	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/02 08:23

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S86	2144383	defect\$5 damag\$6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/02 08:23
S93	6995003	inspect\$6 compar\$3 determin\$6 test\$3 check\$6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/06 15:28
S95	950947	S93 and S94	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/06 15:29
S94	3126757	"and" nand	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/06 15:29
S98	361989	pixel	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/06 15:30
S97	191826	S95 and S96	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/06 15:30
S96	2223793	display	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/06 15:30
S99	29601	S97 and S98	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/06 15:31

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S10 6	362266	pixel	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/07 07:33
S10 5	191975	S103 and S104	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/07 07:33
S10 4	2224695	display	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/07 07:33
S10 3	951387	S101 and S102	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/07 07:33
S10 2	3127269	"and" nand	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/07 07:33
S10 1	6997446	inspect\$6 compar\$3 determin\$6 test\$3 check\$6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/07 07:33
S10 0	22606	(inspect\$4 checking test\$3) adj circuit	US-PGPUB; USPAT	OR	ON	2006/11/07 07:33
S10 8	476	S100 and S107	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/07 07:35
S10 7	29633	S105 and S106	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/07 07:35

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S11 0	54	S108 and S109	US-PGPUB; USPAT	OR	ON	2006/11/07 07:36
S10 9	14814	((327/291) or (348/180) or (345/94,92,104,100,98,87,76,204, 208) or (315/169.1-169.4) or (326/9,11-14,52,54)).CCLS.	US-PGPUB; USPAT	OR	OFF	2006/11/07 07:36

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	5180	((327/291) or (348/180) or (345/94,92,104,100,98,87,76,204,208) or (315/169.1-169.4) or (326/9,11-14,52,54)).CCLS.	US-PGPUB	OR	OFF	2006/11/10 11:37
L2	711	(NAND and driv\$3).clm.	US-PGPUB	OR	ON	2006/11/10 11:42
L3	39	1 and 2	US-PGPUB	OR	ON	2006/11/10 11:42

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1	INZZ	display	unrestricted	126382	<a href="#">show titles</a>
2	INZZ	test\$3	unrestricted	941900	<a href="#">show titles</a>
3	INZZ	NAND	unrestricted	2959	<a href="#">show titles</a>
4	INZZ	1 AND 2 AND 3	unrestricted	5	<a href="#">show titles</a>

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